Se	arch l	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	-
10/607,871	MCVOY ET AL.	
Examiner	Art Unit	
Joon H. Hwang	2166	

	SEARCHED		
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARC)
• .	DATE	EXMR
inventor searched See search history printout(s)	12/1/2006	JH
	•	
٠.		
<u> </u>		
·		